

PATENT  
450117-03249

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Zhaocheng WANG et al.  
Filed: Filed Concurrently Herewith  
Title of Invention: PILOT PATTERN DESIGN FOR A STTL  
SCHEME IN AN OFDM SYSTEM

1c5566 U.S. PTO  
09/898389



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INFORMATION DISCLOSURE STATEMENT

Assistant Commissioner for Patents  
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Sir:


Enclosed are copies of references which were cited in  
the search report of December 6, 2000 from the European Patent  
Office in connection with the corresponding European patent  
application. Also enclosed is a copy of Form PTO-1449. Entry of  
this Information Disclosure Statement and an early examination on  
the merits are respectfully solicited.

PATENT  
450117-03249

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Respectfully submitted,

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Based on Form PTO-1449 (3/90)	ATTY. DOCKET NO. 450117-03249	SERIAL NO. Filed Concurrently Herein
	APPLICANT Zhaocheng WANG et al.	
	FILING DATE Filed Concurrently Herewith	GROUP

LIST OF REFERENCES CITED BY APPLICANT  
(Use several sheets if necessary)

JP 09/03/01  
09/03/01  
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U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	5 867 478	02/02/99	Baum et al.			
	AB	6 005 876	12/21/99	Cimini, Jr. et al.			
	AC						
	AD						
	AE						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AL	EP 0 938 208	08/25/99	Europe			
	AM						
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OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
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